

**Notice of References Cited**

Application/Control No.

10/506,418

Applicant(s)/Patent Under  
Reexamination  
WANG ET AL.

Examiner

Liam J. Heincer

Art Unit

1796

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Yoo et al. (Journal of Applied Polymer Science, Vol. 83, 767-776, 2002) (Available online 11/20/2001)
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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